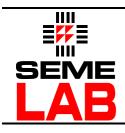
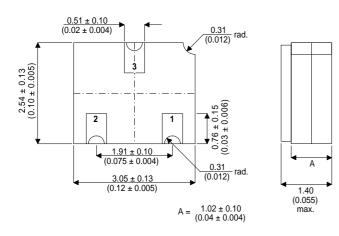
2N3209XCSM



MECHANICAL DATA

Dimensions in mm (inches)



HIGH SPEED PNP SWITCHING TRANSISTOR FOR HIGH RELIABILITY APPLICATIONS

FEATURES

- SILICON PLANAR EPITAXIAL PNP TRANSISTOR
- HERMETIC CERAMIC SURFACE MOUNT PACKAGE (SOT23 COMPATIBLE)
- SCREENING OPTIONS AVAILABLE
- SPACE QUALITY LEVEL OPTIONS
- HIGH SPEED SATURATED SWITCHING

LCC1 (SOT23) PAD 1 – Base PAD 2 – Emitter PAD 3 – Collector

APPLICATIONS

For high reliability general purpose applications requiring small size and low weight devices.

ABSOLUTE MAXIMUM RATINGS

T _{CASE} = 25℃ unless otherwise stated			
V _{CBO}	Collector - Base Voltage	-20V	
V _{CEO}	Collector - Emitter Voltage ($I_B = 0$)	-20V	
V _{EBO}	Emitter – Base Voltage ($I_C = 0$)	-4.0V	
I _C	Continuous Collector Current	-200mA	
PD	Total Power Dissipation at $T_{case} \le 25^{\circ}$	300mW	
	De-Rate above: $T_{case} \le 50^{\circ}C$	2.20m₩/℃	
T_{stg},T_{J}	Operating and Storage Temperature Range	-55 to +200℃	

THERMAL DATA

R _{0JA} Thermal Resistance Junction - Ambient	Max	420	CW
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ELECTRICAL CHARACTERISTICS (T_{case}=25[°]C unless otherwise stated)

	Parameter Test Conditions		tions	Min.	Тур.	Max.	Unit
V _{(BR)CEO*}	Collector - Emitter Breakdown Voltage	I _C = 10mA					
$V_{(BR)CBO^{\star}}$	Collector - Base Breakdown Voltage	$I_{\rm C} = 10 \mu A$		-20	-	-	V
$V_{(BR)EBO^{\star}}$	Emitter - Base Breakdown Voltage	$I_{\rm C} = 0$	$I_E = 10 \mu A$	-4.0	-	-	
I _{CES*}	Collector Cut-Off Current	$V_{BE} = 0V$	$V_{CE} = -10V$	-	-	-80	nA
			T _C = 125℃	-	-	-10	μA
V _{CE(sat)} *		I _C = -10mA	I _B = -1.0mA	-	-	-0.20	
	Collector - Emitter Saturation Voltage	I _C = -30mA	I _B = -3mA	-	-	-0.25	V
		I _C = -100mA	$I_B = -10 \text{mA}$	-	-	-0.75	
V _{BE(sat)} *	Base - Emitter Saturation Voltage	I _C = -10mA	I _B = -1.0mA	-0.78	-	-0.98	V
		I _C = -30mA	I _B = -3mA	-0.85	-	-1.2	
		I _C = -100mA	I _B = -10mA	-	-	-1.7	
h _{FE} *	DC Current Gain	I _C = -10mA	$V_{CE} = -0.3V$	25	-	-	
		I _C = -30mA	$V_{CE} = -0.5V$	30	-	120	
			T _{AMB} = -55℃	12	-	-	
		I _C = -100mA	V _{CE} = -1.0V	15	-	-	
DYNA		ase=25℃ unless	otherwise stated)				
f _T	Transition Frequency	I _C = -30mA	V _{CE} = -10V	100		-	MHz
		f = 100MHz		400	-		
		$I_{\rm C} = 0$	V _{EB} = -0.5V				
CIBO	Emitter - Base Capacitance			-	-	6.0	pF

C _{IBO}	Emitter - Base Capacitance	f = 1.0MHz		-	-	6.0	р⊦	
C _{OBO}	Collector - Base Capacitance	$I_E = 0$	$V_{CB} = -5V$	-	-	5.0	pF	
		f = 1.0MHz						
t _{on}	Turn-On Time	$V_{CC} = -2V$	$I_{\rm C}$ = -30mA	-	-	60	200	
t _{off}	Turn-Off Time	I _{B1} =-1.5mA	I _{B2} =- I _{B1}	-	-	90	ns	

* Pulse test t_p = 300µs, δ < 2%

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